Application/Control No. Applicant(s)/Patent Under Reexamination 09/684,389 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 KIEU-OANH T. BUI 2611 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 10-2000 US-6,133,910 Stinebruner, Scott A. 725/49 Α US-5,982,411 11-1999 Eyer et al. 725/49 В US-С US-D US-Е US-F US-G US-Н US-1 US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) ٧ W

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